

**FCC ID:2AIOOH30**

**Portable device**

According to §15.247(e)(i) and §1.1307(b)(1), systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the Commission's guidelines.

According to KDB447498 D01 General RF Exposure Guidance V05

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances  $\leq$  50 mm are determined by:

$[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] * [\sqrt{f(\text{GHz})}] \leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, where}$

$f(\text{GHz})$  is the RF channel transmit frequency in GHz;

Power and distance are rounded to the nearest mW and mm before calculation;

The result is rounded to one decimal place for comparison;

The test exclusions are applicable only when the minimum test separation distance is  $\leq$  50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is  $<$  5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

We use 5mm as separation distance to calculate.

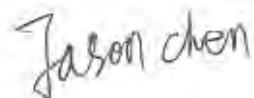
Maximum measured transmitter power:

**BLE:**

Modulation	Channel Freq. (MHz)	Conducted power (dBm)	Conducted power (mW)	Tune-up power (dBm)	Max tune-up power (dBm)	Max tune-up power (mW)	Result calculation	1g SAR
GFSK	2402	-3.266	0.47	-3±1	-2.00	0.63	0.19558	3.00
	2440	-3.692	0.43	-3±1	-2.00	0.63	0.19700	3.00
	2480	-3.957	0.40	-3±1	-2.00	0.63	0.19873	3.00

**Conclusion:**

For the max result :  $0.19873 \leq 3.0$  for 1-g SAR, No SAR is required.

A handwritten signature in black ink that reads "Jason chen". The signature is fluid and cursive, with "Jason" on the top line and "chen" on the bottom line.

**Signature:**

**Date:** 2016-12-31

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